## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Group Art Unit: To Be Assigned

Examiner: To Be Assigned In re PATENT APPLICATION of: Applicant(s) : Toshikazu MIZUKOSHI Appln. No. : To Be Assigned INFORMATION Filed : August 7, 2003 DISCLOSURE **STATEMENT** For : METHOD OF FABRICATING A SEMICONDUCTOR DEVICE HAVING ) TRENCHES Attv. Dkt. : OKI 361 August 7, 2003

Commissioner for Patents P.O. Box 1450 -Alexandria, VA 22313-1450

Sir:

This is an information disclosure statement submitted in compliance with the timing requirements of 37 C.F.R. §1.97(b)(1).

Attached are copies of four Japanese publications and one article. Any relevance of the Japanese publications or article can be gleaned from the attached English-language Abstracts or translations. The publications and article are listed on the attached Form PTO-1449. Also listed on the Form PTO-1449 for consideration are three U.S. patents. Any relevance of these U.S. patents is self-evident.

Since this Information Disclosure Statement is being filed with the application, no certification or fee is required, and the requirements of 37 C.F.R. §§1.97 and 1.98 are deemed to be fully met as to the document submitted. Consideration of the submitted and listed documents is respectfully requested.

> RABIN & BERDO, P.C. CUSTOMER NO. 23995

Respectfully submitted,

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RHB:tz

FORM PTO-1449				Atty Docket	Applica	Application No.		
INFORMATION DISCLOSURE STATEMENT				OKI 361	To Be	To Be Assigned		
				Applicant				
				Toshikazu MIZUKOSHI				
						Community		
				Filing Date	Group Unit			
				August 7, 2003	To Be Assigned			
U.S. PATENT DOCUMENTS								
Examiner Initial		Document Number	Date	Name	Class	Sub- Class	Filing Date	
	AA	6,268,629	07/31/01	Noguchi				
	AB	6,245,684	06/12/01	Zhao et al.				
	AC	6,051,479	04/18/00	Hong	T			
	AD			,				
	AE							
	AF							
	AG							
	AH							
	AI							
	AJ							
FOREIGN PATENT DOCUMENTS								
		Document Number	Date	Country	Class	Sub- Class	Trans- lation	
	AK	2001-244327	09/07/01	Japan			Abstract	
	AL	2000-101071	04/07/00	Japan			Abstract	
	AM	11-102961	04/13/99	Japan	T		Abstract	
	AN	10-223747	08/21/98	Japan			Abstract	
OTHER (Including Author, Title, Date, Pertinent Pages, etc.)								
	AO	1991.3, Semiconductor World, p128-p131, and translation thereof.						
	AP							
	AQ							
	AR							
Examiner Date Considered								
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through								

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.